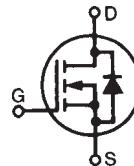


PolarHV™ HiPerFET Power MOSFET

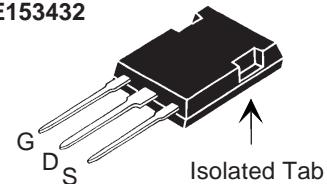
(Electrically Isolated Back Surface)

N-Channel Enhancement Mode
Avalanche Rated
Fast Intrinsic Diode



V_{DSS}	=	800	V
I_{D25}	=	13	A
$R_{DS(on)}$	\leq	420	$m\Omega$
t_{rr}	\leq	200	ns

ISOPLUS247 (IXFR)
 E153432



G = Gate D = Drain
S = Source

Symbol	Test Conditions	Maximum Ratings		
V_{DSS}	$T_J = 25^\circ C$ to $150^\circ C$	800	V	
V_{DGR}	$T_J = 25^\circ C$ to $150^\circ C$; $R_{GS} = 1 M\Omega$	800	V	
V_{GSS}	Continuous	± 30	V	
V_{GSM}	Transient	± 40	V	
I_{D25}	$T_c = 25^\circ C$	13	A	
I_{DM}	$T_c = 25^\circ C$, pulse width limited by T_{JM}	55	A	
I_{AR}	$T_c = 25^\circ C$	12	A	
E_{AR}	$T_c = 25^\circ C$	50	mJ	
E_{AS}	$T_c = 25^\circ C$	1.5	J	
dv/dt	$I_s \leq I_{DM}$, $di/dt \leq 100 A/\mu s$, $V_{DD} \leq V_{DSS}$, $T_J \leq 150^\circ C$, $R_G = 2 \Omega$	10	V/ns	
P_D	$T_c = 25^\circ C$	208	W	
T_J		-55 ... +150	$^\circ C$	
T_{JM}		150	$^\circ C$	
T_{stg}		-55 ... +150	$^\circ C$	
T_L	1.6 mm (0.062 in.) from case for 10 s	300	$^\circ C$	
T_{SOLD}	Plastic body for 10 s	260	$^\circ C$	
V_{ISOL}	50/60 Hz, RMS, 1 minute	2500	V~	
F_c	Mounting force	20..120/4.6..27	N/lb	
Weight		5	g	

Features

- Silicon chip on Direct-Copper-Bond substrate
 - High power dissipation
 - Isolated mounting surface
 - 2500V electrical isolation
- International standard package
- Fast recovery diode
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
 - easy to drive and to protect

Symbol	Test Conditions ($T_J = 25^\circ C$, unless otherwise specified)	Characteristic Values			Advantages
		Min.	Typ.	Max.	
BV_{DSS}	$V_{GS} = 0 V$, $I_D = 250 \mu A$	800		V	
$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 4 mA$	3.0		5.0 V	
I_{GSS}	$V_{GS} = \pm 30 V$, $V_{DS} = 0 V$			$\pm 100 nA$	
I_{DSS}	$V_{DS} = V_{DSS}$ $V_{GS} = 0 V$			25 μA 1000 μA	
$R_{DS(on)}$	$V_{GS} = 10 V$, $I_D = I_T$ (note 1) Pulse test, $t \leq 300 \mu s$, duty cycle $d \leq 2 \%$			420 $m\Omega$	

Symbol Test Conditions

Characteristic Values

(T_J = 25°C, unless otherwise specified)

Min. Typ. Max.

g_{fs}	V _{DS} = 20 V; I _D = I _T , pulse test	15	25	S
C_{iss} C_{oss} C_{rss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz	7200	pF	
		470	pF	
		26	pF	
t_{d(on)} t_r t_{d(off)} t_f	V _{GS} = 10 V, V _{DS} = 0.5 V _{DSS} , I _D = I _T R _G = 2 Ω (External)	32	ns	
		27	ns	
		75	ns	
		24	ns	
Q_{g(on)} Q_{gs} Q_{gd}	V _{GS} = 10 V, V _{DS} = 0.5 V _{DSS} , I _D = I _T	105	nC	
		30	nC	
		33	nC	
R_{thJC}			0.6 °C/W	
R_{thCS}		0.15		°C/W

Note 1: Test current I_T = 12 A

Source-Drain Diode

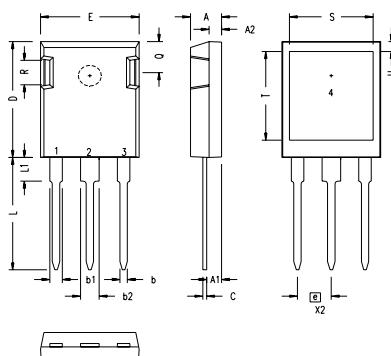
Characteristic Values

(T_J = 25°C, unless otherwise specified)

Min. Typ. Max.

I_s	V _{GS} = 0 V		24	A
I_{SM}	Repetitive		55	A
V_{SD}	I _F = I _s , V _{GS} = 0 V, Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %		1.5	V
t_{rr} Q_{RM}	I _F = 25A, -di/dt = 100 A/μs V _R = 100V, V _{GS} = 0 V		250	ns
			0.8	μC
			6.0	A

ISOPLUS247 (IXFR) Outline



SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.045	.055	1.14	1.40
b1	.075	.084	1.91	2.13
b2	.115	.123	2.92	3.12
C	.024	.031	0.61	0.80
D	.819	.840	20.80	21.34
E	.620	.635	15.75	16.13
e	.215 BSC		5.45 BSC	
L	.780	.800	19.81	20.32
L1	.150	.170	3.81	4.32
Q	.220	.244	5.59	6.20
R	.170	.190	4.32	4.83
S	.520	.540	13.21	13.72
T	.620	.640	15.75	16.26
U	.065	.080	1.65	2.03

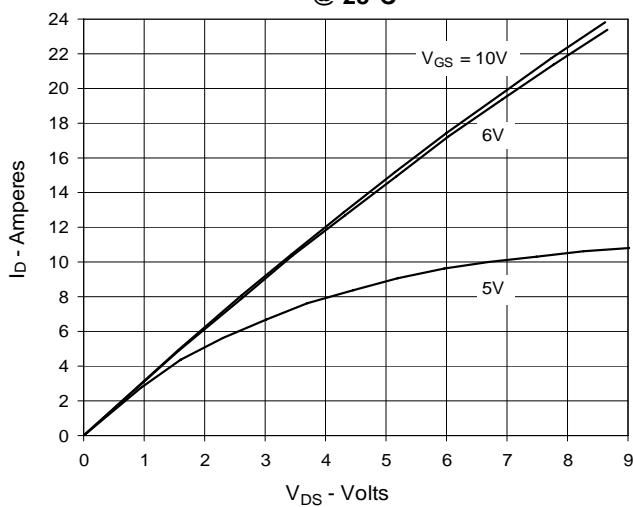
- 1 – GATE
2 – DRAIN (COLLECTOR)
3 – SOURCE (EMITTER)
4 – NO CONNECTION

NOTE: This drawing will meet all dimensions requirement of JEDEC outline TO-247AD except screw hole.

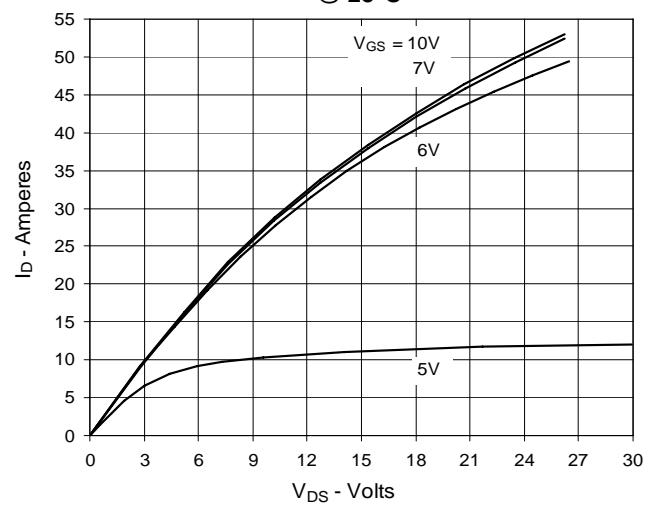
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 one or more of the following U.S. patents: 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405B2 6,759,692 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2

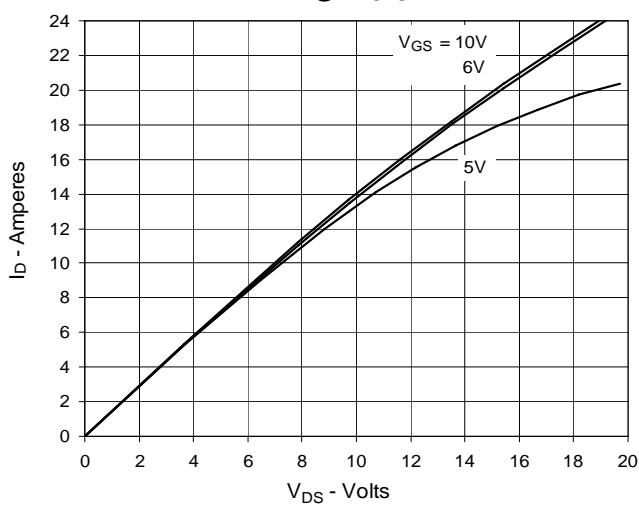
**Fig. 1. Output Characteristics
@ 25°C**



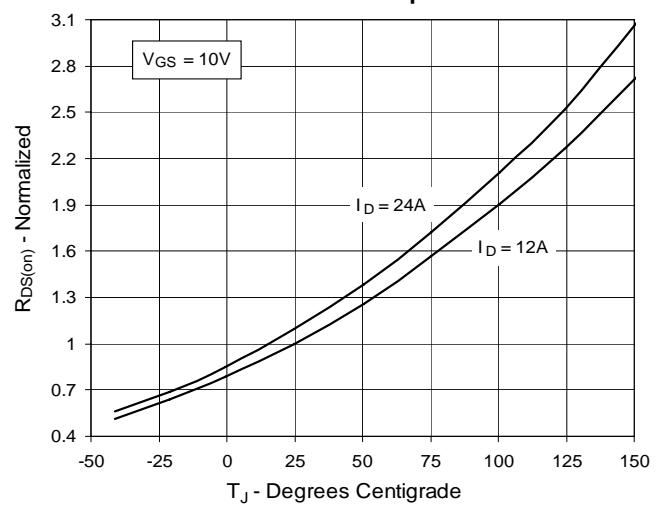
**Fig. 2. Extended Output Characteristics
@ 25°C**



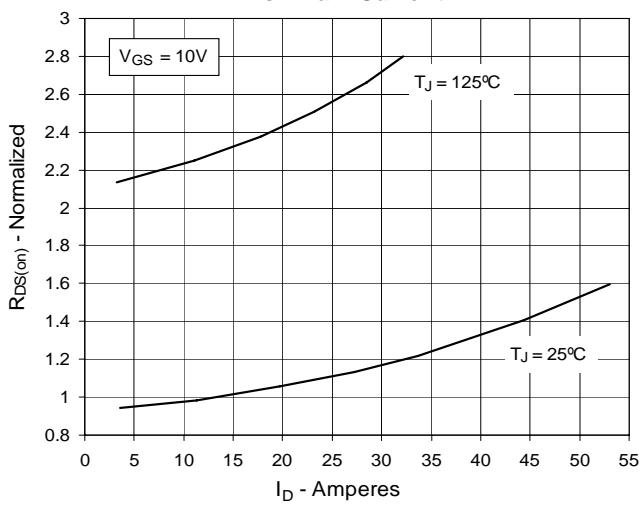
**Fig. 3. Output Characteristics
@ 125°C**



**Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 12A$ Value
vs. Junction Temperature**



**Fig. 5. $R_{DS(on)}$ Normalized to $I_D = 12A$ Value
vs. Drain Current**



**Fig. 6. Maximum Drain Current vs.
Case Temperature**

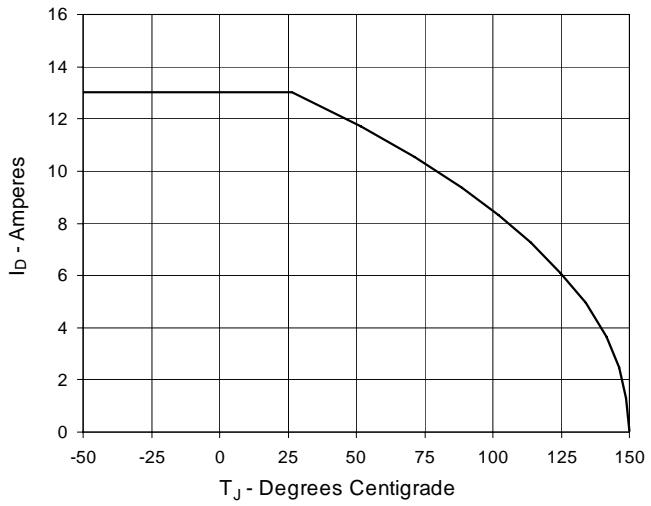
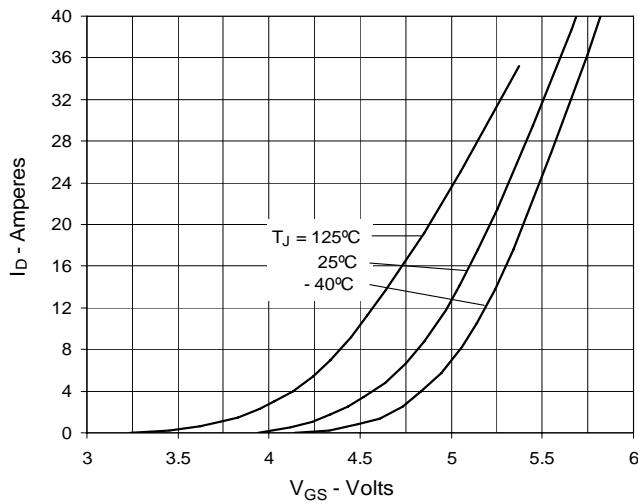
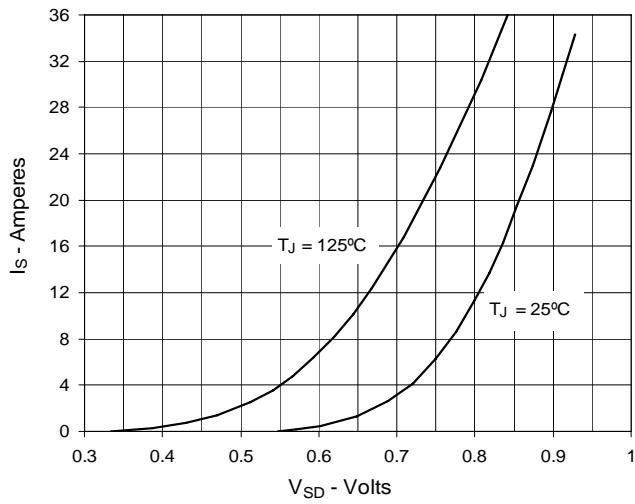
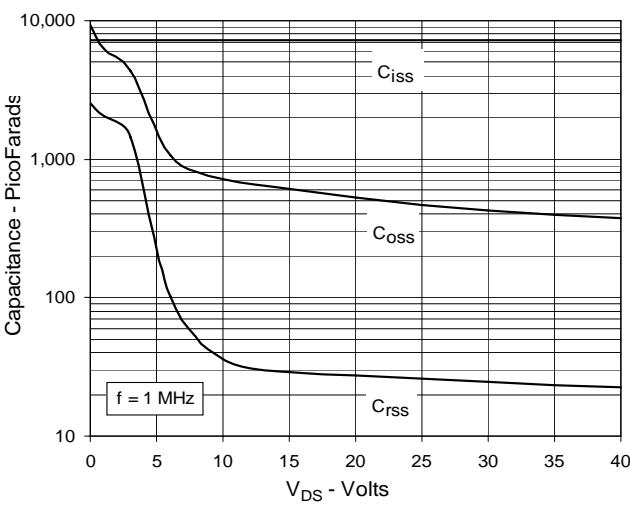
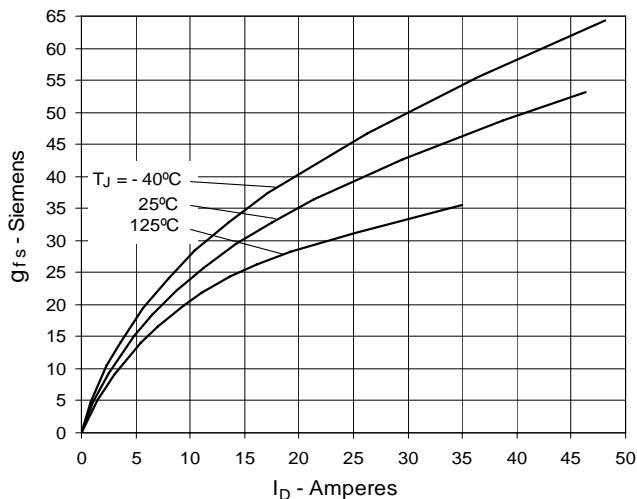
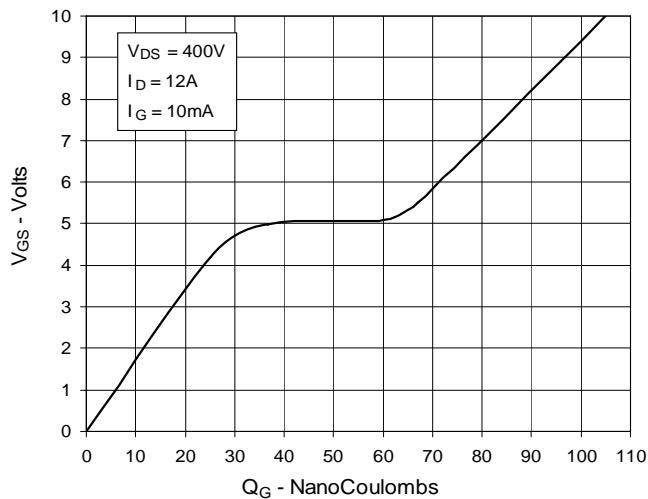


Fig. 7. Input Admittance**Fig. 9. Forward Voltage Drop of Intrinsic Diode****Fig. 11. Capacitance****Fig. 8. Transconductance****Fig. 10. Gate Charge****Fig. 12. Maximum Transient Thermal Resistance**